

Notice of References Cited		Application/Control No. 10/596,717	Applicant(s)/Patent Under Reexamination DENOON-STEVENS ET AL.	
		Examiner STEPHEN CLAWSON	Art Unit 4172	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,787,258	07-1998	Costa et al.	709/251
*	B	US-2003/0017845	01-2003	Doviak et al.	455/556
*	C	US-2002/0159402	10-2002	Binder, Yehuda	370/296
*	D	US-2003/0084112	05-2003	Curray et al.	709/208
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Desmarais, Louis. Applied Electro-Optics. Prentice Hall. 12/5/1997 pg. 244
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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